

Positive Fixed 5V Low Dropout Voltage Regulator in bare die form

Rev 1.0 19/04/19

Description

The LM3480-5 is a 5V fixed 3-terminal voltage regulator delivering up to 100mA of output current and equipped with internal limiting + thermal shutdown features for overload immunity. The device is a smaller and electrically improved replacement for the industry standard 78L05. The device accepts higher 30V input voltage & exhibits a maximum drop-out voltage of 1.2V across the full military temperature range. The device suits use as a post-regulator in switching DC/DC converters or as a bias supply in analog circuits.

Ordering Information

The following part suffixes apply:

- No suffix MIL-STD-883 /2010B Visual Inspection.
- "H" MIL-STD-883 /2010B Visual Inspection
 + MIL-PRF-38534 Class H LAT
- "K" MIL-STD-883 /2010A Visual Inspection (Space)
 + MIL-PRF-38534 Class K (AT)

LAT = Lot Acceptance Test.

For further information on LAT places flows see below.

www.siliconsupplies.com\quality\bare-die-lot-qualification

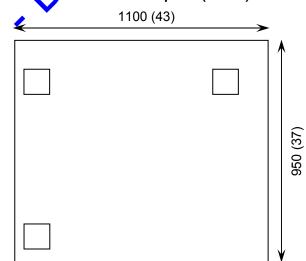
Supply Formats:

- Defaut Die in Waffle Pack (400 per tray capacity)
- Sawn Wafer on Tape On request
- Un-sawn Wafer On request
- With Ti/Ni/Ag Back Metal On request
- In Metal or Ceramic package On request

Features:

- Wide input voltage range up to 30
- 900mV dropout voltage typical
- 100mA output current
- Internal thermal overload protection
- Internal short-circuit current limit
- Full military temperature range
- Smaller electrical upgrade for 78L05 series.

Die Qimensions in µm (mils)



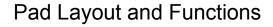
Mechanical Specification

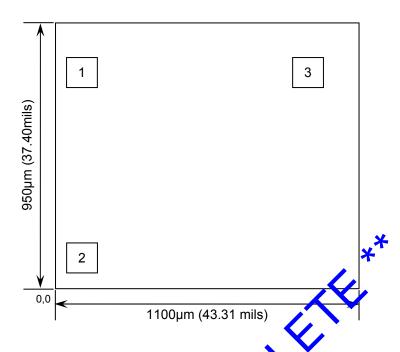
Die Size (Unsawn)	1100 x 950 43.31 x 37.40	µm mils	
Minimum Bond Pad Size	96 x 96 3.78 x 3.78	μm mils	
Die Thickness	280 (±20) 11 (±0.8)		
Top Metal Composition	Al 1%Si 1.4μm		
Back Metal Composition	N/A – Bare Si		





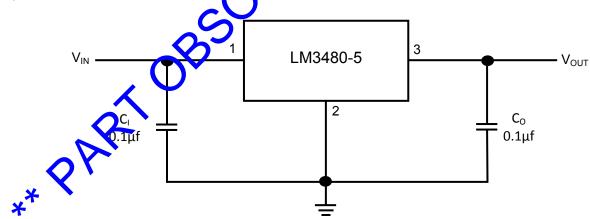
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PAD	FUNCTION	CCOPINATES (µm)			
IAD	I discribit	X	Υ		
1	V _{IN}	92	747		
2	GND	92	107		
3	У от	899	747		
COUNEDT CHIP BACK TO GND					

Typical Application



Application Notes:

 $0.1 \,\mu$ F is the minimum C_l & C_o value required for stability & adequate transient performance. There is no specific ESR limitation, although excessively high ESR will compromise transient performance. There is no specific limitation on a maximum capacitance value on either input or output. Larger output capacitor values can be used to improve transient behaviour.

The device can operate with up to 30V input voltage supply. This input supply must be well regulated. Additional low ESR input capacitance improves the output noise performance if the input supply is noisy.





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Absolute Maximum Ratings¹ T_J = 25°C unless otherwise stated

PARAMETER	SYMBOL	VALUE	UNIT
Input Voltage (V _{IN} to GND)	V _{IN}	-0.3 to 35	V
Power Dissipation ²	P _D	Internally limited	n.W
Operating Temperature Range	T _J	-55 to 125	C
Maximum Junction Temperature	T _J	150	°C
Storage Temperature	T _{STG}	-65 to 150	°C
ESD Human-body model (HBM)	-	2	kV

Operating Conditions T_J = 25°C unless otherwise stated

PARAMETER	SYMBOL	MIN	MAX	UNIT	
Input Voltage	V _{IN}		30	V	
Output Current	I _{OUT}		100	mA	
Operating Temperature Range	T _J	-55	+125	°C	

DC Electrical Characteristics T_J = 25°C unless otherwise specified

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Output Voltage	V _{OUT}	$V_{IN} = V_{OUT} + 1.3V$ $1 \text{mA} \le I_O \le 100 \text{n.A}$	$T_J = 25^{\circ}C$	4.80	5.00	5.20	V
			Full range ³	4.75	-	5.25	
Line Regulation	ΔV _{OUT}	$V_{OUT}+1.57 \le V_{IN} \le 30V$	$T_J = 25^{\circ}C$	-	12	-	mV
Line regulation	A 6 001	l _o =(m/k	Full range ³	-ull range ³ -	-	25	
Load Regulation	ion ΔV _{OUT}	$V_{IN} = V_{OUT} + 1.5V,$ $0 \text{m/} \le I_O \le 100 \text{mA}$	$T_J = 25^{\circ}C$	-	20	-	
			Full range ³	-	-	40	
Ground Pin Current	I _{GND}	V _{JUT} +1.5V ≤V _{IN} ≤30V, No load	T _J = 25°C	-	3	-	mA
			Full range ³	-	-	4	
Ground Pin Current	Ground Pin Current $V_{OUT} + 1.5V \le V_{IN} \le 2$		V, I _O =40mA	-	-	- 1.4	
Change	Δcus	$V_{IN} = V_{OUT} + 5V \le V_{IN} \le 20V,$ $1mA \le I_O \le 40mA$	-	-	0.5	mA	
Output noise voltage	e _n	V_{IN} = 10V, f = 10Hz – 100kHz, I_{O} =1mA, C_{OUT} = 0.1uF		-	150	-	μV_{RMS}
Dropout Voltage	$V_{IN} - V_{OUT}$ $I_O = 10 \text{mA}$ $I_O = 100 \text{mA}$	_	$T_J = 25^{\circ}C$	-	0.7	0.9	V
			Full range ³	-	-	1	
		I ₂ = 100mΔ	$T_J = 25^{\circ}C$	-	0.9	1.1	V
		Full range ³	-	-	1.2		

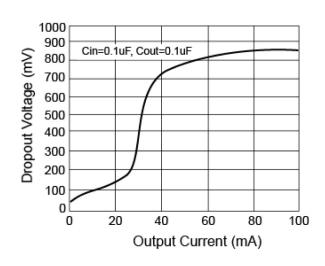
Notes: **1.** Operation above the absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability. **2.** Maximum power dissipation depends on the ambient temperature and can be calculated using $P = (T_J - T_A) / R_{\theta JA}$ where T_J is the junction temperature, T_A is the ambient temperature, and $R_{\theta JA}$ is the junction-to-ambient thermal resistance. Results in die form are dependent on die attach and assembly method, the LM3480 actively limits its junction temperature to ~150°C. **3.** -55°C $\leq T_J \leq 125$ °C





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Typical Performance Characteristics T_J = 25°C unless otherwise specified



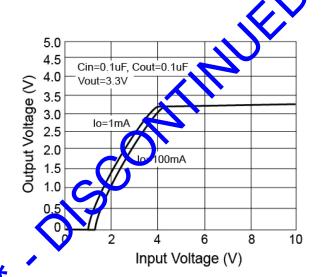
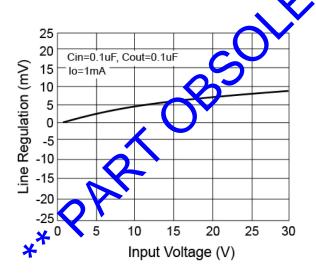


FIGURE 1. Dropout Voltage versus Load Current





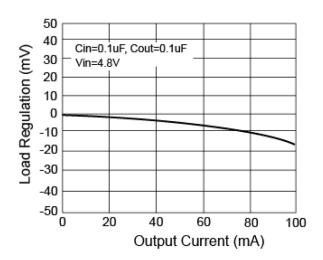


FIGURE 3. Line Regulation

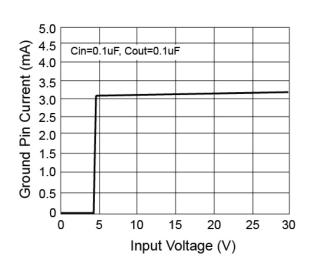
FIGURE 4. Load Regulation





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Typical Performance Characteristics T_J = 25°C unless otherwise specified



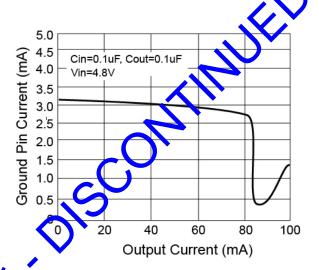


FIGURE 4. Ground Pin Current versus Input Voltage

FIGURE 5. Ground Pin Current versus Output
Current

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